

EAST Search History

Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
L1	4	"6901971".pn.	US-PGPU B; USPAT; USOCR; EPO; JPO; DERWEN T; IBM_TDB	OR	ON	2006/09/18 12:28
L2	1616	environment\$4 near2 (sensor or detector or monitor) and transceiver	US-PGPU B; USPAT; USOCR; EPO; JPO; DERWEN T; IBM_TDB	OR	ON	2006/09/18 12:34
L3	29022	seal\$3 near3 (battery or power)	US-PGPU B; USPAT; USOCR; EPO; JPO; DERWEN T; IBM_TDB	OR	ON	2006/09/18 12:30
L4	11	2 and 3	US-PGPU B; USPAT; USOCR; EPO; JPO; DERWEN T; IBM_TDB	OR	ON	2006/09/18 12:30
L5	13394	(temperature or impact or shock or humidity or ph or strain or light or position or orientation) near3 (sensor or detector or monitor) and transceiver	US-PGPU B; USPAT; USOCR; EPO; JPO; DERWEN T; IBM_TDB	OR	ON	2006/09/18 12:36

EAST Search History

L6	150	3 and 5	US-PGPU B; USPAT; USOCR; EPO; JPO; DERWEN T; IBM_TDB	OR	ON	2006/09/18 12:35
L7	171	(temperature or impact or shock or humidity or ph or strain or light or position or orientation) near3 (sensor or detector or monitor) same (simulat\$3 or mimic\$5) and transceiver	US-PGPU B; USPAT; USOCR; EPO; JPO; DERWEN T; IBM_TDB	OR	ON	2006/09/18 12:38
L8	0	3 and 7	US-PGPU B; USPAT; USOCR; EPO; JPO; DERWEN T; IBM_TDB	OR	ON	2006/09/18 12:37
L9	9	(temperature or impact or shock or humidity or ph or strain or light or position or orientation or environment\$3) near3 (sensor or detector or monitor) same durable near3 good	US-PGPU B; USPAT; USOCR; EPO; JPO; DERWEN T; IBM_TDB	OR	ON	2006/09/18 12:48
L10	739876	(temperature or impact or shock or humidity or ph or strain or light or position or orientation or environment\$3) near3 (sensor or detector or monitor)	US-PGPU B; USPAT; USOCR; EPO; JPO; DERWEN T; IBM_TDB	OR	ON	2006/09/18 14:14

EAST Search History

L11	20655	(plural\$5 or multiple) near5 (printed near2 circuit near2 boards or pcbs)	US-PGPU B; USPAT; USOCR; EPO; JPO; DERWEN T; IBM_TDB	OR	ON	2006/09/18 12:50
L12	1666	10 and 11	US-PGPU B; USPAT; USOCR; EPO; JPO; DERWEN T; IBM_TDB	OR	ON	2006/09/18 12:51
L13	1701	(plural\$5 or multiple) near5 (printed near2 circuit near2 boards or pcbs) with solder\$3	US-PGPU B; USPAT; USOCR; EPO; JPO; DERWEN T; IBM_TDB	OR	ON	2006/09/18 12:50
L14	58	10 and 13	US-PGPU B; USPAT; USOCR; EPO; JPO; DERWEN T; IBM_TDB	OR	ON	2006/09/18 13:01
L15	377867	10.ab,ti.	US-PGPU B; USPAT; USOCR; EPO; JPO; DERWEN T; IBM_TDB	OR	ON	2006/09/18 13:01

EAST Search History

L16	69188	15 and (power or battery)	US-PGPU B; USPAT; USOCR; EPO; JPO; DERWEN T; IBM_TDB	OR	ON	2006/09/18 13:04
L17	1038	16 and transceiver	US-PGPU B; USPAT; USOCR; EPO; JPO; DERWEN T; IBM_TDB	OR	ON	2006/09/18 13:03
L18	1710	15 and transceiver	US-PGPU B; USPAT; USOCR; EPO; JPO; DERWEN T; IBM_TDB	OR	ON	2006/09/18 13:03
L19	149	18 and (power or battery) and (printed near3 circuit near2 board or pcb)	US-PGPU B; USPAT; USOCR; EPO; JPO; DERWEN T; IBM_TDB	OR	ON	2006/09/18 14:13
L20	1019	egg near3 handling	US-PGPU B; USPAT; USOCR; EPO; JPO; DERWEN T; IBM_TDB	OR	ON	2006/09/18 14:14

EAST Search History

L21	316	20.ab,ti.	US-PGPU B; USPAT; USOCR; EPO; JPO; DERWEN T; IBM_TDB	OR	ON	2006/09/18 14:14
L22	0	21 and (wireless or transceiver)	US-PGPU B; USPAT; USOCR; EPO; JPO; DERWEN T; IBM_TDB	OR	ON	2006/09/18 14:14
L23	1149	egg and (wireless or transceiver)	US-PGPU B; USPAT; USOCR; EPO; JPO; DERWEN T; IBM_TDB	OR	ON	2006/09/18 14:14
L24	431	10 and 23	US-PGPU B; USPAT; USOCR; EPO; JPO; DERWEN T; IBM_TDB	OR	ON	2006/09/18 14:19
L25	11	10.ab,ti. and 23	US-PGPU B; USPAT; USOCR; EPO; JPO; DERWEN T; IBM_TDB	OR	ON	2006/09/18 14:15

EAST Search History

L26	26	340/693.8.ccls.	US-PGPU B; USPAT; USOCR; EPO; JPO; DERWEN T; IBM_TDB	OR	ON	2006/09/18 14:20
L27	87	340/673.ccls.	US-PGPU B; USPAT; USOCR; EPO; JPO; DERWEN T; IBM_TDB	OR	ON	2006/09/18 14:21
L28	3	"4989462".uref,bi.	US-PGPU B; USPAT; USOCR; EPO; JPO; DERWEN T; IBM_TDB	OR	ON	2006/09/18 14:54
L29	0	1 and (circuit near 2 boards or pcb)	US-PGPU B; USPAT; USOCR; EPO; JPO; DERWEN T; IBM_TDB	OR	ON	2006/09/18 14:55
L30	1	1 and (board or pcb)	US-PGPU B; USPAT; USOCR; EPO; JPO; DERWEN T; IBM_TDB	OR	ON	2006/09/18 15:22

EAST Search History

L31	1	"6817757".pn. and board	US-PGPU B; USPAT; USOCR; EPO; JPO; DERWEN T; IBM_TDB	OR	ON	2006/09/18 15:46
L32	1	10/796042	US-PGPU B; USPAT; USOCR; EPO; JPO; DERWEN T; IBM_TDB	OR	ON	2006/09/18 15:46
S1	10954	(impact or environment\$3) near3 (detector or sensor or monitor).ab,ti.	US-PGPU B; USPAT; USOCR; EPO; JPO; DERWEN T; IBM_TDB	OR	ON	2006/09/14 17:38
S2	372	S1 and (mimic\$6 or simulat\$3)	US-PGPU B; USPAT; USOCR; EPO; JPO; DERWEN T; IBM_TDB	OR	ON	2006/09/14 16:51
S3	32	S2 and transceiver	US-PGPU B; USPAT; USOCR; EPO; JPO; DERWEN T; IBM_TDB	OR	ON	2006/09/14 17:01

EAST Search History

S4	213	S1 and transceiver	US-PGPU B; USPAT; USOCR; EPO; JPO; DERWEN T; IBM_TDB	OR	ON	2006/09/14 17:01
S5	181	S4 not S3	US-PGPU B; USPAT; USOCR; EPO; JPO; DERWEN T; IBM_TDB	OR	ON	2006/09/14 17:01
S6	4163	(impact) near3 (detector or sensor or monitor).ab, ti.	US-PGPU B; USPAT; USOCR; EPO; JPO; DERWEN T; IBM_TDB	OR	ON	2006/09/14 17:38
S7	6	S6 and egg	US-PGPU B; USPAT; USOCR; EPO; JPO; DERWEN T; IBM_TDB	OR	ON	2006/09/14 17:39
S8	243	simulat\$3 near3 egg	US-PGPU B; USPAT; USOCR; EPO; JPO; DERWEN T; IBM_TDB	OR	ON	2006/09/14 17:39

EAST Search History

S9	1	simulat\$3 near3 egg near4 (impact\$3 or shock)	US-PGPU B; USPAT; USOCR; EPO; JPO; DERWEN T; IBM_TDB	OR	ON	2006/09/14 17:40
S10	0	simulat\$3 near3 fragile near4 (impact\$3 or shock)	US-PGPU B; USPAT; USOCR; EPO; JPO; DERWEN T; IBM_TDB	OR	ON	2006/09/14 17:40
S11	0	simulat\$3 near3 fragile and (impact\$3 or shock). ab,ti.	US-PGPU B; USPAT; USOCR; EPO; JPO; DERWEN T; IBM_TDB	OR	ON	2006/09/14 17:40
S12	0	mimic\$5 near3 fragile and (impact\$3 or shock).ab,ti.	US-PGPU B; USPAT; USOCR; EPO; JPO; DERWEN T; IBM_TDB	OR	ON	2006/09/18 10:52